

**Notice of References Cited**

Application/Control No.

09/627,725

Applicant(s)/Patent Under  
Reexamination  
OYABU ET AL.

Examiner

Son P Huynh

Art Unit

2611

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	U	US 2003/0088872 A1 (Maissel et al. ) May 8, 2003, 725/46
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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